intersil™

OBSOLETE PRODUCT
POSSIBLE SUBSTITUTE PRODUCT
X95840
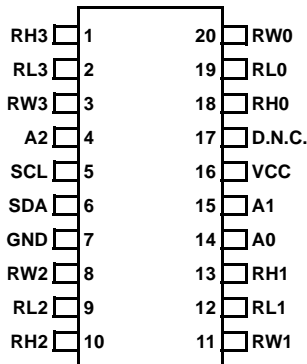
Low Noise, Low Power I²C® Bus, 256 Taps

The ISL90840 integrates four digitally controlled potentiometers (XDCP) on a monolithic CMOS integrated circuit.

The digitally controlled potentiometers are implemented with a combination of resistor elements and CMOS switches. The position of the wipers are controlled by the user through the I²C bus interface. Each potentiometer has an associated volatile Wiper Register (WR) that can be directly written to and read by the user. The contents of the WR controls the position of the wiper. When powered on the ISL90810's wiper will always commence at mid-scale (128 tap position).

The DCPs can be used as three-terminal potentiometers or as two-terminal variable resistors in a wide variety of applications including control, parameter adjustments, and signal processing.

Features

- Four potentiometers in one package

- 256 resistor taps - 0.4% resolution

- I²C serial interface
  - Three address pins, up to eight devices/bus
  - Write/Read capability

- Power-on preset to mid-scale (128 tap position)

- Wiper resistance: 70Ω typical @ 3.3V

- Standby current <5μA max

- Power supply: 2.7V to 5.5V

- 50kΩ, 10kΩ total resistance

- 20 Ld TSSOP package

- Pb-free plus anneal available (RoHS compliant)

Pinout

ISL90840
(20 LD TSSOP)
TOP VIEW

Pin		Pin	
RH3	1	20	RW0
RL3	2	19	RL0
RW3	3	18	RH0
A2	4	17	D.N.C.
SCL	5	16	VCC
SDA	6	15	A1
GND	7	14	A0
RW2	8	13	RH1
RL2	9	12	RL1
RH2	10	11	RW1

Ordering Information

| PART NUMBER	PART MARKING	RESIST-ANCE OPTION (Ω)	TEMP RANGE (°C)	PACKAGE	PKG. DWG #
ISL90840UIV2027Z (Notes 1 and 2)	ISL90840UI27Z	50k	-40 to +85	20 Ld TSSOP (Pb-free)	MDP0044
ISL90840UIV2027	ISL90840UI27	50k	-40 to +85	20 Ld TSSOP	MDP0044
ISL90840UAV2027Z (Notes 1 and 2)	ISL90840UA27Z	50k	-40 to +105	20 Ld TSSOP (Pb-free)	MDP0044
ISL90840WIV2027Z (Notes 1 and 2)	ISL90840WI27Z	10k	-40 to +85	20 Ld TSSOP (Pb-free)	MDP0044
ISL90840WIV2027	ISL90840WI27	10k	-40 to +85	20 Ld TSSOP	MDP0044
ISL90840WAV2027Z (Notes 1 and 2)	ISL90840WA27Z	10k	-40 to +105	20 Ld TSSOP (Pb-free)	MDP0044

NOTES:

1. Intersil Pb-free plus anneal products employ special Pb-free material sets; molding compounds/die attach materials and 100% matte tin plate termination finish, which are RoHS compliant and compatible with both SnPb and Pb-free soldering operations. Intersil Pb-free products are MSL classified at Pb-free peak reflow temperatures that meet or exceed the Pb-free requirements of IPC/JEDEC J STD-020.

2. Add "T2" suffix for tape and reel.

Functional Diagram
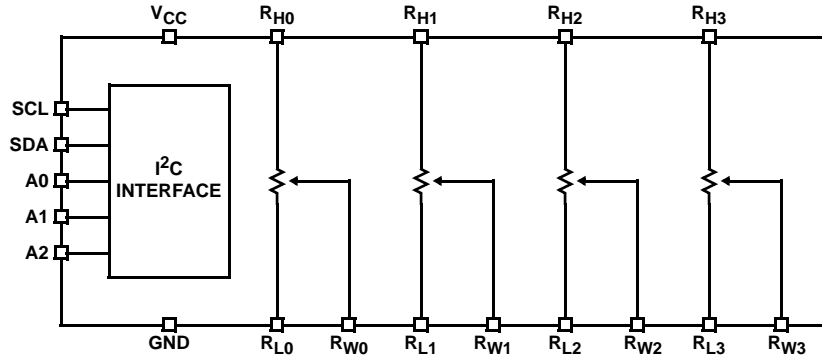
Block Diagram
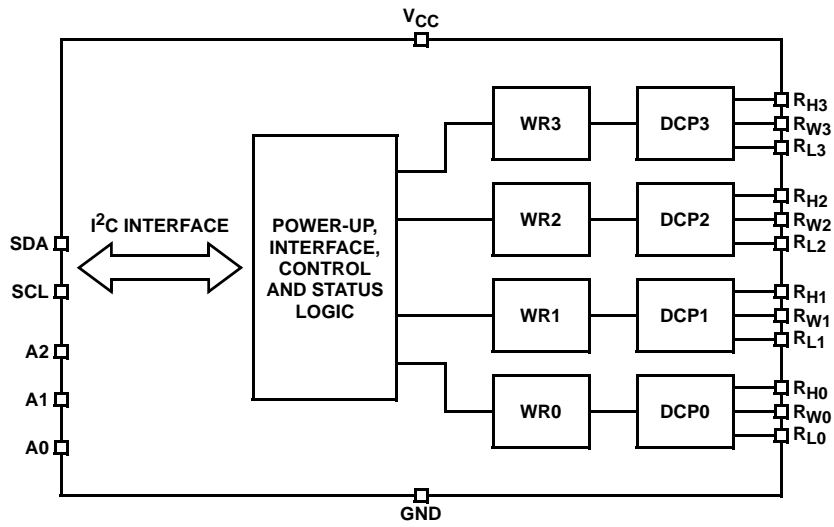
Pin Descriptions

TSSOP PIN	SYMBOL	DESCRIPTION
1	RH3	"High" terminal of DCP3
2	RL3	"Low" terminal of DCP3
3	RW3	"Wiper" terminal of DCP3
4	A2	Device address for the I^{2}C interface
5	SCL	I^{2}C interface clock
6	SDA	Serial data I/O for the I^{2}C interface
7	GND	Device ground pin
8	RW2	"Wiper" terminal of DCP2
9	RL2	"Low" terminal of DCP2
10	RH2	"High" terminal of DCP2
11	RW1	"Wiper" terminal of DCP1
12	RL1	"Low" terminal of DCP1
13	RH1	"High" terminal of DCP1
14	A0	Device address for the I^{2}C interface
15	A1	Device address for the I^{2}C interface
16	VCC	Power supply pin
17	D.N.C.	Do not connect
18	RH0	"High" terminal of DCP0
19	RL0	"Low" terminal of DCP0
20	RW0	"Wiper" terminal of DCP0

ISL90840

Absolute Maximum Ratings

Storage Temperature . . . . -65°C to +150°C
Voltage at Any Digital Interface Pin
    With Respect to V_{SS} . . . . -0.3V to V_{CC}+0.3V
V_{CC} . . . . -0.3V to +6V
Voltage at Any DCP Pin
    With Respect to V_{SS} . . . . -0.3V to V_{CC}
Lead Temperature (Soldering, 10s) . . . . +300°C
I_W (10s) . . . . ±6mA
Latchup . . . . Class II, Level A @ +105°C
ESD
    HBM 2.5kV

Thermal Information

Thermal Resistance (Typical, Note 3) θ_{JA} (°C/W)
    20 Ld TSSOP Package   90
Maximum Junction Temperature (Plastic Package). . . . .+150°C

Recommended Operating Conditions

Industrial . . . .-40°C to +85°C
Automotive. . . . .-40°C to +105°C
V_{CC} . . . . 2.7V to 5.5V
Power Rating. 5mW
Wiper Current . . . .±3.0mA

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

NOTES:

3. θ_{JA} is measured with the component mounted on a high effective thermal conductivity test board in free air. See Tech Brief TB379 for details.

Analog Specifications   Over recommended operating conditions unless otherwise stated.

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP (NOTE 4)	MAX	UNIT
R_{TOTAL}	R_H to R_L resistance	W option		10		kΩ
		U option		50		kΩ
	R_H to R_L resistance tolerance		-20		+20	%
R_W	Wiper resistance	V_{CC} = 3.3V @ +25°C, wiper current = V_{CC}/R_{TOTAL}		70	200	Ω
$C_H/C_L/C_W$	Potentiometer capacitance (Note 18)			10/10/25		pF
I_{LkgDCP}	Leakage on DCP pins (Note 18)	Voltage at pin from GND to V_{CC}		0.1	1	µA
VOLTAGE DIVIDER MODE (0V @ R_Li; V_{CC} @ R_Hi; measured at R_Wi, unloaded; i = 0, 1, 2, or 3)						
INL (Note 9)	Integral non-linearity		-1		1	LSB (Note 5)
DNL (Note 8)	Differential non-linearity	Monotonic over all tap positions	-0.5		0.5	LSB (Note 5)
ZSerror (Note 6)	Zero-scale error	W option	0	1	7	LSB (Note 5)
		U option	0	0.5	2	
FSerror (Note 7)	Full-scale error	W option	-7	-1	0	LSB (Note 5)
		U option	-2	-1	0	
V_{MATCH} (Note 10)	DCP to DCP matching	Any two DCPs at same tap position, same voltage at all R_H terminals, and same voltage at all R_L terminals	-2		2	LSB (Note 5)
TC_V (Note 11)	Ratiometric temperature coefficient	DCP register set to 80 hex		±4		ppm/°C
RESISTOR MODE (Measurements between R_Wi and R_Li with R_Hi not connected, or between R_Wi and R_Hi with R_Li not connected. i = 0, 1, 2 or 3)						
RINL (Note 15)	Integral non-linearity	DCP register set between 20 hex and FF hex; monotonic over all tap positions	-1		1	MI (Note 12)
RDNL (Note 14)	Differential non-linearity		-0.5		0.5	MI (Note 12)
Roffset (Note 13)	Offset	W option	0	1	7	MI (Note 12)
		U option	0	0.5	2	
R_{MATCH} (Note 16)	DCP to DCP matching	Any two DCPs at the same tap position with the same terminal voltages	-2		2	MI (Note 12)

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November 14, 2006

Analog Specifications   Over recommended operating conditions unless otherwise stated. **(Continued)**

| SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP (NOTE 4)	MAX	UNIT
TC_R (Note 17)	Resistance temperature coefficient	DCP register set between 20 hex and FF hex		±45		ppm/°C

Operating Specifications   Over the recommended operating conditions unless otherwise specified.

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP (NOTE 4)	MAX	UNIT
I_{CC1}	V_{CC} supply current (volatile write/read)	f_{SCL} = 400kHz; SDA = Open; (for I^{2}C, active, read and write states)			1	mA
I_{SB}	V_{CC} current (standby)	V_{CC} = +5.5V, I^{2}C Interface in Standby State, Temperature range from -40°C to 85°C		2	5	µA
		V_{CC} = +5.5V, I^{2}C Interface in Standby State, Temperature range from -40°C to 105°C		2	8	µA
		V_{CC} = +3.6V, I^{2}C Interface in Standby State, Temperature range from -40°C to 85°C		0.8	2	µA
		V_{CC} = +3.6V, I^{2}C Interface in Standby State, Temperature range from -40°C to 105°C		0.8	5	µA
I_{LkgDig}	Leakage current, at pins A0, A1, A2, SDA, and SCL	Voltage at pin from GND to V_{CC}	-10		10	µA
t_{DCP} (Note 18)	DCP wiper response time	SCL falling edge of last bit of DCP data byte to wiper change		1		µs
SERIAL INTERFACE SPECS						
V_{IL}	A2, A1, A0, SDA, and SCL input buffer LOW voltage		-0.3		0.3*V_{CC}	V
V_{IH}	A2, A1, A0, SDA, and SCL input buffer HIGH voltage		0.7*V_{CC}		V_{CC}+0.3	V
Hysteresis (Note 18)	SDA and SCL input buffer hysteresis		0.05*V_{CC}			V
V_{OL} (Note 18)	SDA output buffer LOW voltage, sinking 4mA		0		0.4	V
Cpin (Note 18)	A2, A1, A0, SDA, and SCL pin capacitance				10	pF
f_{SCL}	SCL frequency				400	kHz
t_{IN} (Note 18)	Pulse width suppression time at SDA and SCL inputs	Any pulse narrower than the max spec is suppressed			50	ns
t_{AA} (Note 18)	SCL falling edge to SDA output data valid	SCL falling edge crossing 30% of V_{CC}, until SDA exits the 30% to 70% of V_{CC} window			900	ns
t_{BUF} (Note 18)	Time the bus must be free before the start of a new transmission	SDA crossing 70% of V_{CC} during a STOP condition, to SDA crossing 70% of V_{CC} during the following START condition	1300			ns
t_{LOW}	Clock LOW time	Measured at the 30% of V_{CC} crossing	1300			ns
t_{HIGH}	Clock HIGH time	Measured at the 70% of V_{CC} crossing	600			ns
$t_{SU:STA}$	START condition setup time	SCL rising edge to SDA falling edge; both crossing 70% of V_{CC}	600			ns
$t_{HD:STA}$	START condition hold time	From SDA falling edge crossing 30% of V_{CC} to SCL falling edge crossing 70% of V_{CC}	600			ns
$t_{SU:DAT}$	Input data setup time	From SDA exiting the 30% to 70% of V_{CC} window, to SCL rising edge crossing 30% of V_{CC}	100			ns
$t_{HD:DAT}$	Input data hold time	From SCL rising edge crossing 70% of V_{CC} to SDA entering the 30% to 70% of V_{CC} window	0			ns

Operating Specifications Over the recommended operating conditions unless otherwise specified. **(Continued)**

SYMBOL	PARAMETER	TEST CONDITIONS	MIN	TYP (NOTE 4)	MAX	UNIT
$t_{SU:STO}$	STOP condition setup time	From SCL rising edge crossing 70% of V_{CC}, to SDA rising edge crossing 30% of V_{CC}	600			ns
$t_{HD:STO}$	STOP condition hod time for read, or volatile only write	From SDA rising edge to SCL falling edge; both crossing 70% of V_{CC}	600			ns
t_{DH} (Note 18)	Output data hold time	From SCL falling edge crossing 30% of V_{CC}, until SDA enters the 30% to 70% of V_{CC} window	0			ns
t_R (Note 18)	SDA and SCL rise time	From 30% to 70% of V_{CC}	20 + 0.1 * Cb		250	ns
t_F (Note 18)	SDA and SCL fall time	From 70% to 30% of V_{CC}	20 + 0.1 * Cb		250	ns
Cb (Note 18)	Capacitive loading of SDA or SCL	Total on-chip and off-chip	10		400	pF
Rpu (Note 18)	SDA and SCL bus pull-up resistor off-chip	Maximum is determined by t_R and t_F For Cb = 400pF, max is about 2~2.5kΩ. For Cb = 40pF, max is about 15~20kΩ	1			kΩ
$t_{SU:A}$	A2, A1 and A0 setup time	Before START condition	600			ns
$t_{HD:A}$	A2, A1 and A0 hold time	After STOP condition	600			ns

NOTES:

4. Typical values are for T_A = 25°C and 3.3V supply voltage.

5. LSB: $[V(R_W)_{255} - V(R_W)_0]/255$. $V(R_W)_{255}$ and $V(R_W)_0$ are $V(R_W)$ for the DCP register set to FF hex and 00 hex respectively. LSB is the incremental voltage when changing from one tap to an adjacent tap.

6. ZS error = $V(R_W)_0/LSB$.

7. FS error = $[V(R_W)_{255} - V_{CC}]/LSB$.

8. DNL = $[V(R_W)_i - V(R_W)_{i-1}]/LSB-1$, for i = 1 to 255. i is the DCP register setting.

9. INL = $[V(R_W)_i - i \cdot LSB - V(R_W)]/LSB$ for i = 1 to 255.

10. $V_{MATCH} = [V(R_Wx)_i - V(R_Wy)_i]/LSB$, for i = 0 to 255, x = 0 to 3 and y = 0 to 3.

11. $TC_V = \dfrac{Max(V(RW)_i) - Min(V(RW)_i)}{[Max(V(RW)_i) + Min(V(RW)_i)]/2} \times \dfrac{10^6}{145°C}$ for i = 16 to 240 decimal, T = -40°C to +105°C. Max( ) is the maximum value of the wiper voltage and Min ( ) is the minimum value of the wiper voltage over the temperature range.

12. MI = $|R_{255} - R_0|/255$. R_{255} and R_0 are the measured resistances for the DCP register set to FF hex and 00 hex respectively.

13. Roffset = R_0/MI, when measuring between R_W and R_L.
    Roffset = R_{255}/MI, when measuring between R_W and R_H.

14. RDNL = $(R_i - R_{i-1})/MI-1$, for i = 32 to 255.

15. RINL = $[R_i - (MI \cdot i) - R_0]/MI$, for i = 32 to 255.

16. $R_{MATCH} = (R_{i,x} - R_{i,y})/MI$, for i = 0 to 255, x = 0 to 3 and y = 0 to 3.

17. $TC_R = \dfrac{[Max(Ri) - Min(Ri)]}{[Max(Ri) + Min(Ri)]/2} \times \dfrac{10^6}{145°C}$ for i = 32 to 255, T = -40°C to +105°C. Max( ) is the maximum value of the resistance and Min ( ) is the minimum value of the resistance over the temperature range.

18. This parameter is not 100% tested

SDA vs SCL Timing
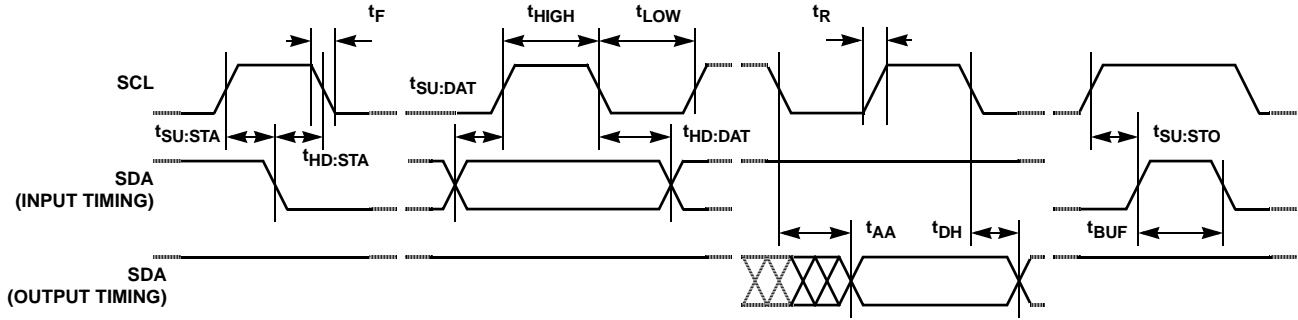
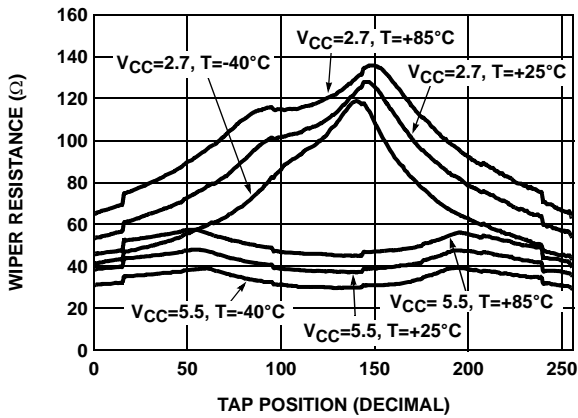## A0, A1, and A2 Pin Timing
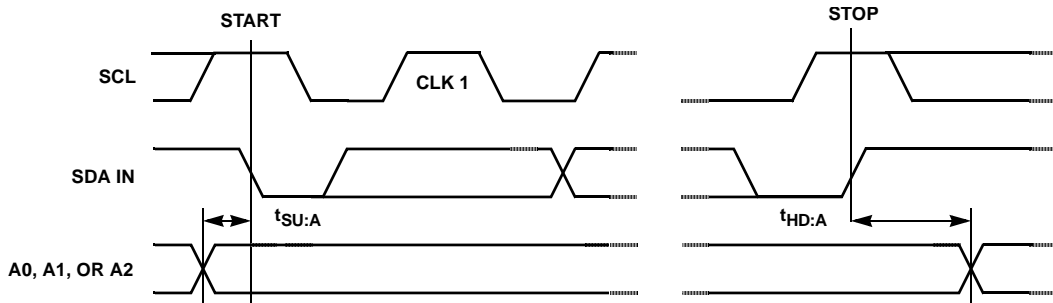
Typical Performance Curves

FIGURE 1. WIPER RESISTANCE vs TAP POSITION
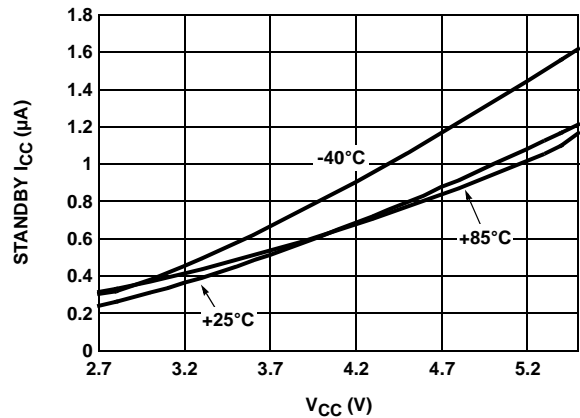[I(RW) = V_{CC} / R_{TOTAL}] FOR 50kΩ (U)

FIGURE 2. STANDBY I_{CC} vs V_{CC}

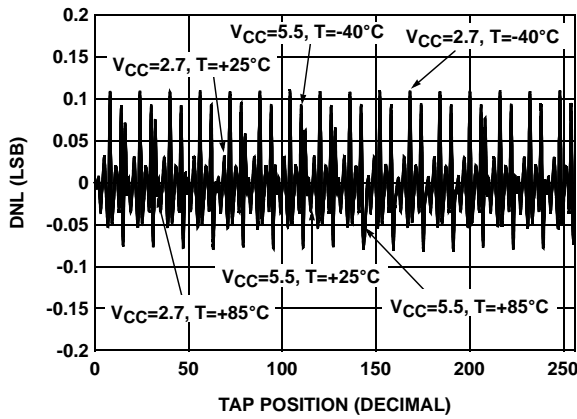## *Typical Performance Curves* (Continued)

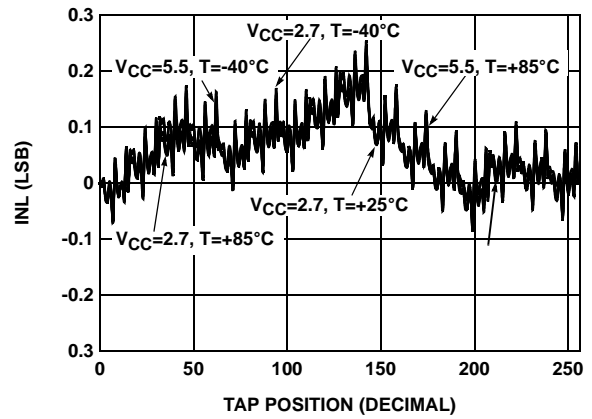FIGURE 3. DNL vs TAP POSITION IN VOLTAGE DIVIDER
MODE FOR 10kΩ (W)

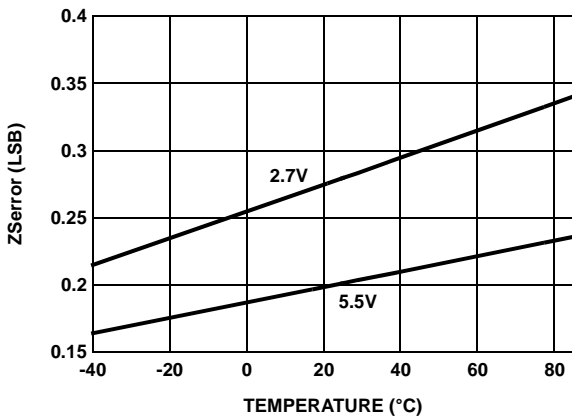FIGURE 4. INL vs TAP POSITION IN VOLTAGE DIVIDER
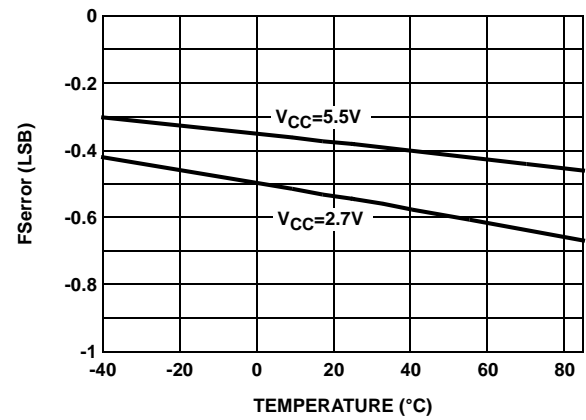MODE FOR 10kΩ (W)

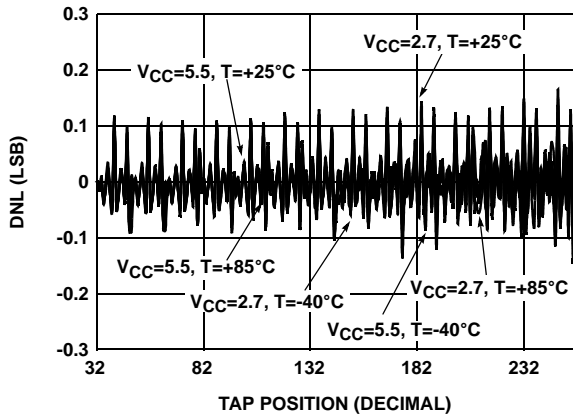FIGURE 5. ZSerror vs TEMPERATURE FOR 50kΩ (W)

FIGURE 6. FSerror vs TEMPERATURE FOR 50kΩ (W)

FIGURE 7. DNL vs TAP POSITION IN RHEOSTAT MODE FOR
50kΩ (U)
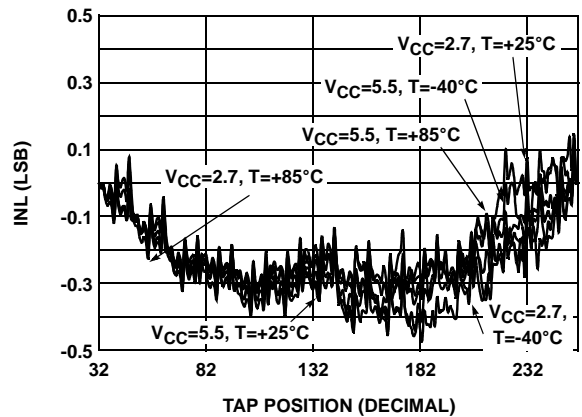
FIGURE 8. INL vs TAP POSITION IN RHEOSTAT MODE FOR
50kΩ (U)

Typical Performance Curves (Continued)
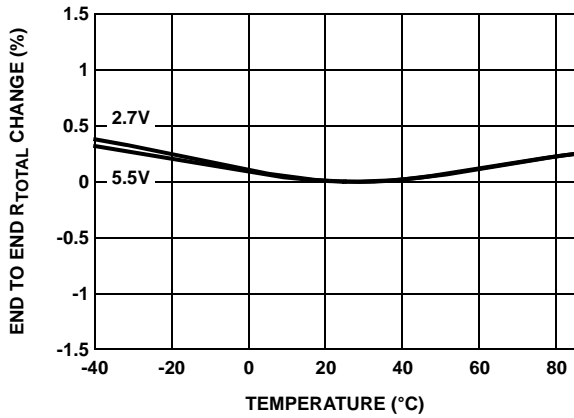
FIGURE 9. END TO END R$_{TOTAL}$ % CHANGE vs TEMPERATURE FOR 50kΩ (W)
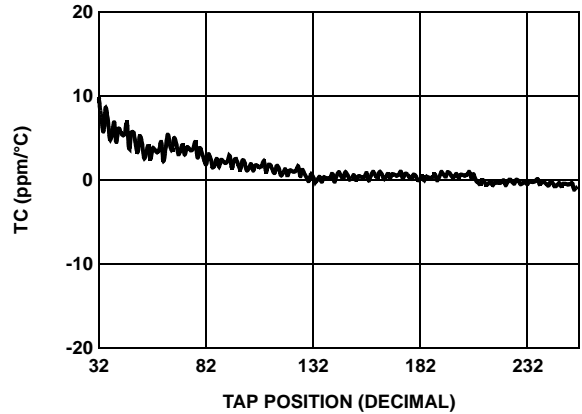
FIGURE 10. TC FOR VOLTAGE DIVIDER MODE IN ppm FOR 50kΩ (W)
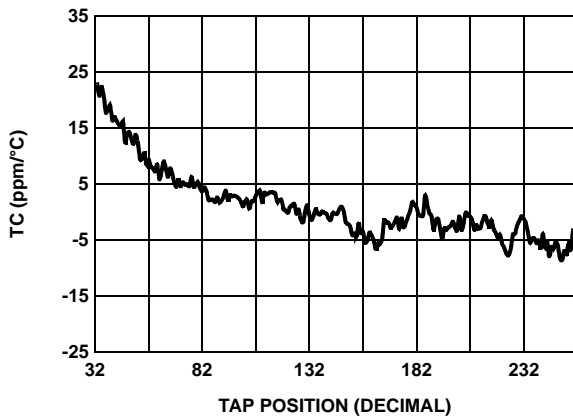
FIGURE 11. TC FOR RHEOSTAT MODE IN ppm FOR 50kΩ (W)
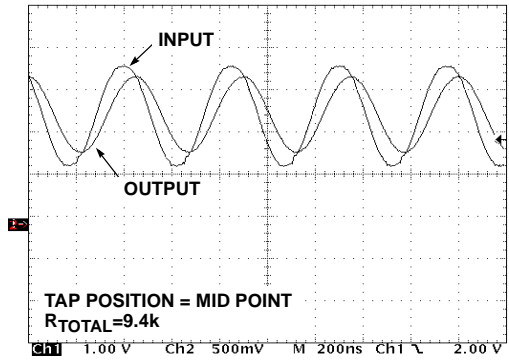
FIGURE 12. FREQUENCY RESPONSE (2.2MHz)
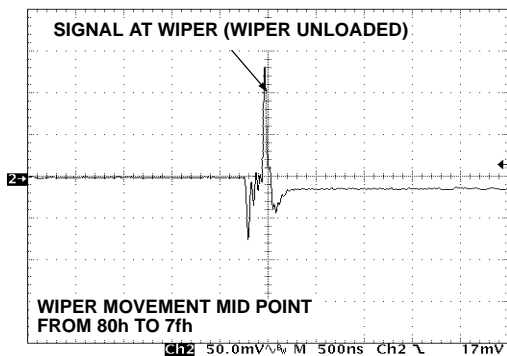
FIGURE 13. MIDSCALE GLITCH, CODE 80h TO 7Fh (WIPER 0)
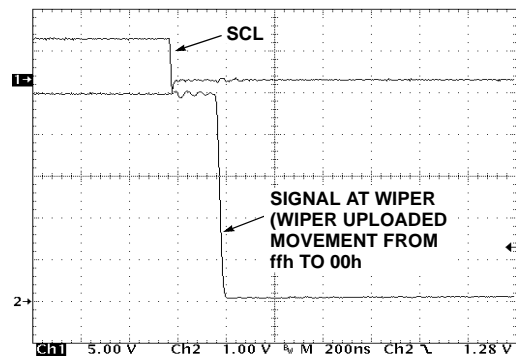
FIGURE 14. LARGE SIGNAL SETTLING TIME

Principles of Operation

The ISL90840 is an integrated circuit incorporating four DCPs with their associated registers, and an I^2C serial interface providing direct communication between a host and the potentiometers.

DCP Description

Each DCP is implemented with a combination of resistor elements and CMOS switches. The physical ends of each DCP are equivalent to the fixed terminals of a mechanical potentiometer (R_H and R_L pins). The R_W pin of each DCP is connected to intermediate nodes, and is equivalent to the wiper terminal of a mechanical potentiometer. The position of the wiper terminal within the DCP is controlled by an 8-bit volatile Wiper Register (WR). Each DCP has its own WR. When the WR of a DCP contains all zeroes (WR[7:0]: 00h), its wiper terminal (R_W) is closest to its "Low" terminal (R_L). When the WR of a DCP contains all ones (WR[7:0]: FFh), its wiper terminal (R_W) is closest to its "High" terminal (R_H). As the value of the WR increases from all zeroes (0 decimal) to all ones (255 decimal), the wiper moves monotonically from the position closest to R_L to the closest to R_H. At the same time, the resistance between R_W and R_L increases monotonically, while the resistance between R_H and R_W decreases monotonically.

While the ISL90840 is being powered up, all four WRs are reset to 80h (128 decimal), which locates R_W roughly at the center between R_L and R_H.

The WRs can be read or written to directly using the I^2C serial interface as described in the following sections. The I^2C interface Address Byte has to be set to 00h, 01h, 02h, and 03h to access the WR of DCP0, DCP1, DCP2, and DCP3 respectively

I^2C Serial Interface

The ISL90840 supports a bidirectional bus oriented protocol. The protocol defines any device that sends data onto the bus as a transmitter and the receiving device as the receiver. The device controlling the transfer is a master and the device being controlled is the slave. The master always initiates data transfers and provides the clock for both transmit and receive operations. Therefore, the ISL90840 operates as a slave device in all applications.

All communication over the I^2C interface is conducted by sending the MSB of each byte of data first.

Protocol Conventions

Data states on the SDA line must change only during SCL LOW periods. SDA state changes during SCL HIGH are reserved for indicating START and STOP conditions (See Figure 15). On power-up of the ISL90840 the SDA pin is in the input mode.

All I^2C interface operations must begin with a START condition, which is a HIGH to LOW transition of SDA while SCL is HIGH. The ISL90840 continuously monitors the SDA and SCL lines for the START condition and does not respond to any command until this condition is met (See Figure 15). A START condition is ignored during the power-up of the device.

All I^2C interface operations must be terminated by a STOP condition, which is a LOW to HIGH transition of SDA while SCL is HIGH (See Figure 15). A STOP condition at the end of a read operation, or at the end of a write operation places the device in its standby mode.

An acknowledge (ACK) is a software convention used to indicate a successful data transfer. The transmitting device, either master or slave, releases the SDA bus after transmitting eight bits. During the ninth clock cycle, the receiver pulls the SDA line LOW to acknowledge the reception of the eight bits of data (See Figure 16).

The ISL90840 responds with an ACK after recognition of a START condition followed by a valid Identification Byte, and once again after successful receipt of an Address Byte. The ISL90840 also responds with an ACK after receiving a Data Byte of a write operation. The master must respond with an ACK after receiving a Data Byte of a read operation

A valid Identification Byte contains 0101 as the four MSBs, and the following three bits matching the logic values present at pins A2, A1, and A0. The LSB is the Read/$\overline{\text{Write}}$ bit. Its value is "1" for a Read operation, and "0" for a Write operation (See Table 1).

TABLE 1. IDENTIFICATION BYTE FORMAT

Logic values at pins A2, A1, and A0 respectively

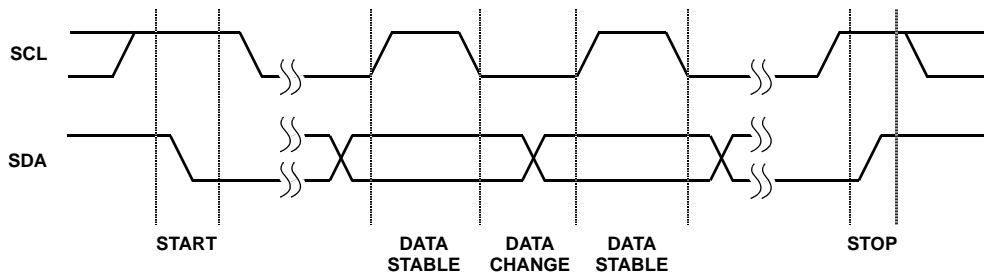| 0	1	0	1	A2	A1	A0	R/$\overline{W}$
(MSB)							(LSB)

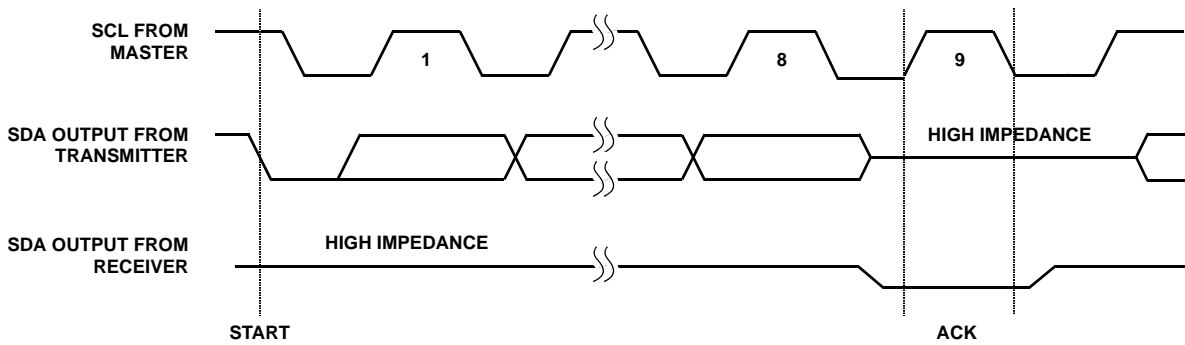FIGURE 15. VALID DATA CHANGES, START, AND STOP CONDITIONS

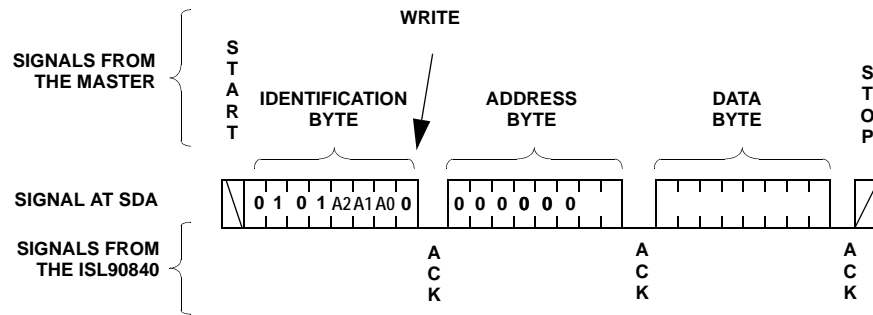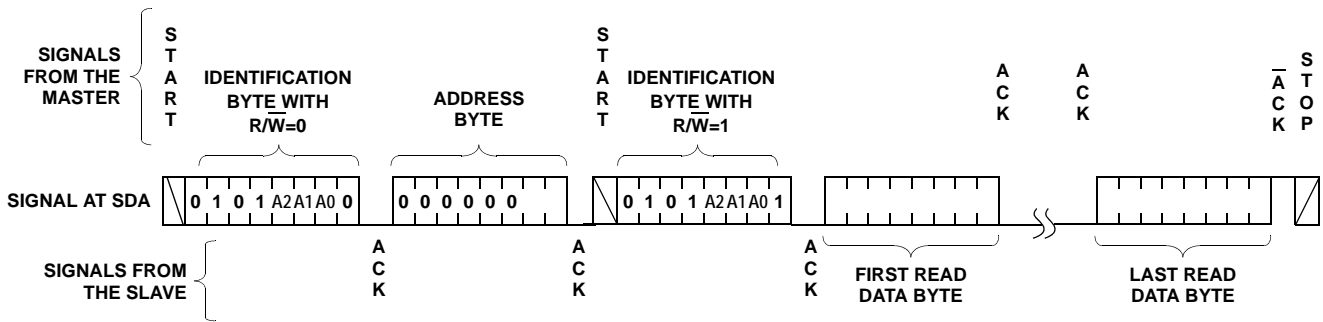FIGURE 16. ACKNOWLEDGE RESPONSE FROM RECEIVER

FIGURE 17. BYTE WRITE SEQUENCE
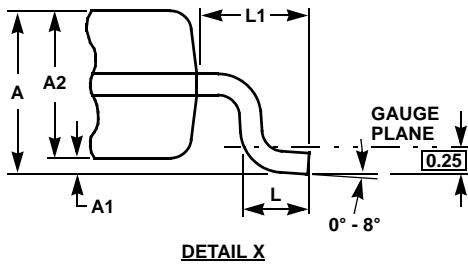

FIGURE 18. READ SEQUENCE
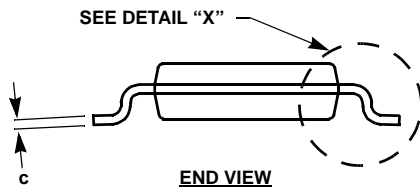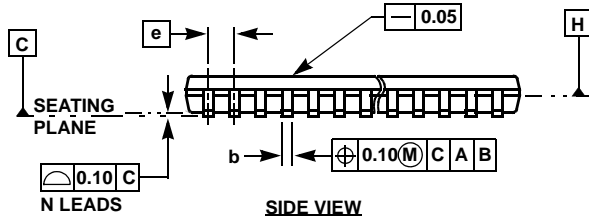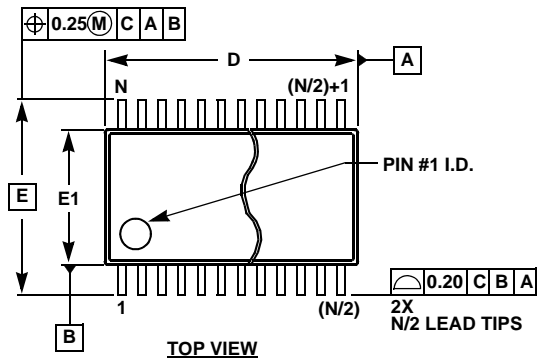
Write Operation

A Write operation requires a START condition, followed by a valid Identification Byte, a valid Address Byte, a Data Byte, and a STOP condition. After each of the three bytes, the ISL90840 responds with an ACK. At this time, the device enters its standby state (See Figure 17).

Read Operation

A Read operation consist of a three byte instruction followed by one or more Data Bytes (See Figure 18). The master initiates the operation issuing the following sequence: a START, the Identification byte with the R/$\overline{W}$ bit set to "0", an Address Byte, a second START, and a second Identification byte with the R/$\overline{W}$ bit set to "1". After each of the three bytes, the ISL90840 responds with an ACK. Then the ISL90840 transmits Data Bytes as long as the master responds with an ACK during the SCL cycle following the eighth bit of each byte. The master terminates the read operation (issuing a $\overline{ACK}$ and STOP condition) following the last bit of the last Data Byte (See Figure 18).

The Data Bytes are from the registers indicated by an internal pointer. This pointer initial value is determined by the Address Byte in the Read operation instruction, and increments by one during transmission of each Data Byte. After reaching the memory location 03h, the pointer "rolls over" to 00h, and the device continues to output data for each ACK received.

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Thin Shrink Small Outline Package Family (TSSOP)

⌖ 0.25 Ⓜ C A B

TOP VIEW

PIN #1 I.D.

2X
N/2 LEAD TIPS
⌒ 0.20 C B A

SEATING PLANE

⌒ 0.10 C
N LEADS

SIDE VIEW

⊕ 0.10 Ⓜ C A B

▭ 0.05

H

SEE DETAIL "X"

END VIEW

DETAIL X

GAUGE PLANE
0.25
0° - 8°

MDP0044

THIN SHRINK SMALL OUTLINE PACKAGE FAMILY

SYMBOL	14 LD	16 LD	20 LD	24 LD	28 LD	TOLERANCE
A	1.20	1.20	1.20	1.20	1.20	Max
A1	0.10	0.10	0.10	0.10	0.10	±0.05
A2	0.90	0.90	0.90	0.90	0.90	±0.05
b	0.25	0.25	0.25	0.25	0.25	+0.05/-0.06
c	0.15	0.15	0.15	0.15	0.15	+0.05/-0.06
D	5.00	5.00	6.50	7.80	9.70	±0.10
E	6.40	6.40	6.40	6.40	6.40	Basic
E1	4.40	4.40	4.40	4.40	4.40	±0.10
e	0.65	0.65	0.65	0.65	0.65	Basic
L	0.60	0.60	0.60	0.60	0.60	±0.15
L1	1.00	1.00	1.00	1.00	1.00	Reference

Rev. E 12/02

NOTES:

1. Dimension "D" does not include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.15mm per side.

2. Dimension "E1" does not include interlead flash or protrusions. Interlead flash and protrusions shall not exceed 0.25mm per side.

3. Dimensions "D" and "E1" are measured at dAtum Plane H.

4. Dimensioning and tolerancing per ASME Y14.5M‑1994.

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